

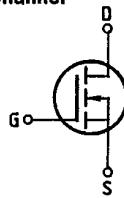
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88D 14624 D T - 39 ~13

BUZ 48

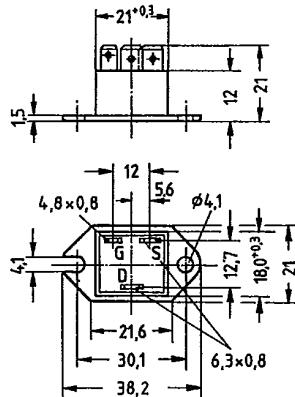
SIEMENS AKTIENGESELLSCHAFT**Main ratings**

Drain-source voltage V_{DS} = 500 V
 Continuous drain current I_D = 7,8 A
 Drain-source on-resistance $R_{DS(on)}$ = 0,6 Ω

N-Channel

Description SIPMOS, N-channel, enhancement mode
Case Plastic package TO 238 AA with insulated metal base plate in accordance with JEDEC, compatible with TO 3; AMP plug-in connections.
 Approx. weight 21 g

Type	Ordering code
BUZ 48	C67078-A1605-A2



Dimensions in mm

Maximum ratings

Description	Symbols	Ratings	Units	Conditions
Drain-source voltage	V_{DS}	500	V	
Drain-gate voltage	V_{DGR}	500	V	$R_{GS} = 20 \text{ k}\Omega$
Continuous drain current	I_D	7,8	A	$T_C = 25^\circ\text{C}$
Pulsed drain current	I_{Dpuls}	31	A	$T_C = 25^\circ\text{C}$
Gate-source voltage	V_{GS}	± 20	V	
Max. power dissipation	P_D	83,3	W	$T_C = 25^\circ\text{C}$
Operating and storage temperature range	T_J	-40 ... +150	°C	
Isolation test voltage	V_{Is}			$t = 1 \text{ min}$
DIN humidity category		3500	Vdc ¹⁾	DIN 40040
IEC climatic category		F	-	DIN IEC 68-1
		40/150/56		

Thermal resistance

Chip – case	$R_{th JC}$	$\leq 1,5$	K/W	
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¹⁾ Isolation test voltage between drain and base plate referred to standard climate 23/50 in accordance with DIN 50014.

SIEMENS AKTIENGESELLSCHAFT**Electrical characteristics**(at $T_J = 25^\circ\text{C}$ unless otherwise specified)

Description	Symbol	Characteristics			Unit	Conditions
		min.	typ.	max.		

Static ratings

Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	500	—	—	V	$V_{GS} = 0\text{V}$ $I_D = 0,25\text{mA}$
Gate threshold voltage	$V_{GS(\text{th})}$	2,1	3,0	4,0		$V_{DS} = V_{GS}$ $I_D = 1\text{mA}$
Zero gate voltage drain current	I_{DSS}	— —	20 100	250 1000	μA	$T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$ $V_{DS} = 500\text{V}$ $V_{GS} = 0\text{V}$
Gate-source leakage current	I_{GSS}	—	10	100	nA	$V_{GS} = 20\text{V}$ $V_{DS} = 0\text{V}$
Drain-source on-resistance	$R_{DS(\text{on})}$	—	0,55	0,6	Ω	$V_{GS} = 10\text{V}$ $I_D = 5\text{A}$

Dynamic ratings

Forward transconductance	g_{fs}	2,7	5,0	—	S	$V_{DS} = 25\text{V}$ $I_D = 5\text{A}$
Input capacitance	C_{iss}	—	3800	4900		$V_{GS} = 0\text{V}$
Output capacitance	C_{oss}	—	250	400		$V_{DS} = 25\text{V}$ $f = 1\text{MHz}$
Reverse transfer capacitance	C_{rss}	—	100	170	ns	$V_{CC} = 30\text{V}$ $I_D = 2,8\text{A}$ $V_{GS} = 10\text{V}$ $R_{GS} = 50\Omega$
Turn-on time t_{on} ($t_{on} = t_{d(on)} + t_r$)	$t_{d(on)}$	—	50	75		
	t_r	—	80	120		
Turn-off time t_{off} ($t_{off} = t_{d(off)} + t_f$)	$t_{d(off)}$	—	330	430		
	t_f	—	110	140		

Reverse diode

Continuous reverse drain current	I_{DR}	—	—	7,8	A	$T_C = 25^\circ\text{C}$
Pulsed reverse drain current	I_{DRM}	—	—	31		
Diode forward on-voltage	V_{SD}	—	1,3	1,6	V	$I_F = 2 \times I_{DR}$ $V_{GS} = 0\text{V}, T_J = 25^\circ\text{C}$
Reverse recovery time	t_{rr}	—	1200	—	ns	$T_J = 25^\circ\text{C}$
Reverse recovery charge	Q_{rr}	—	12	—	μC	$I_F = I_{DR}$ $d_{F/dt} = 100\text{A}/\mu\text{s}$ $V_R = 100\text{V}$

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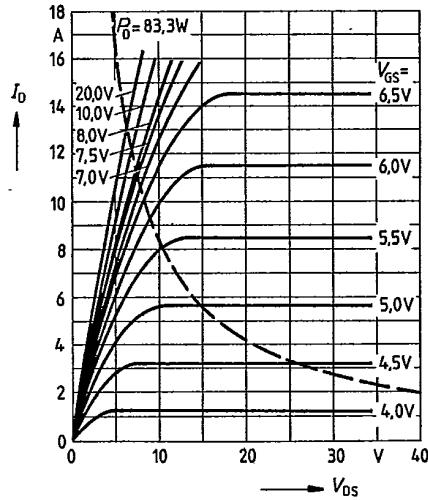
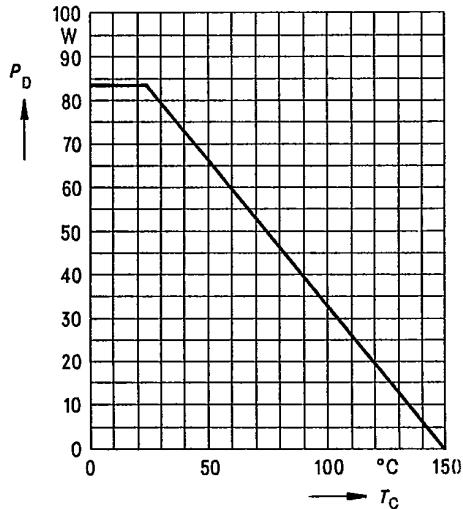
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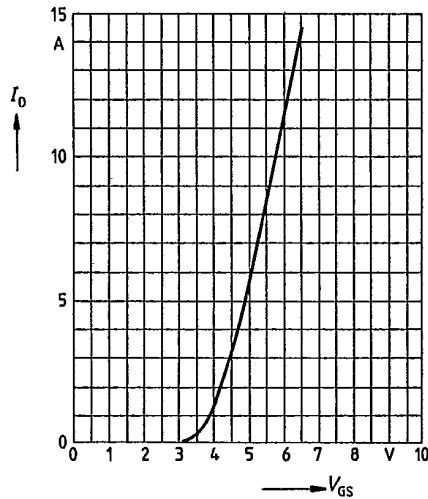
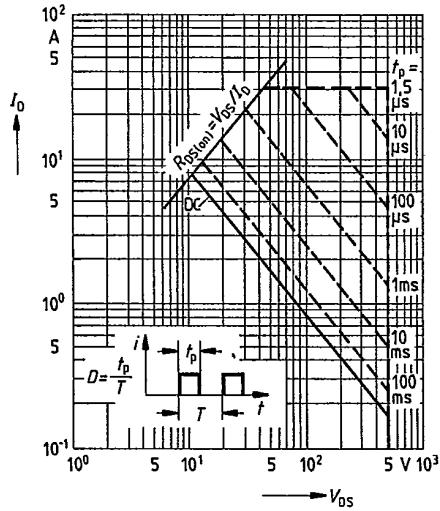
Power dissipation $P_D = f(T_C)$

Typical output characteristics $I_D = f(V_{DS})$
parameter: 80 μ s pulse test,
 $T_j = 25^\circ\text{C}$



Safe operating area $I_D = f(V_{DS})$
parameter: $D = 0.01$, $T_C = 25^\circ\text{C}$

Typical transfer characteristic $I_D = f(V_{GS})$
parameter: 80 μ s pulse test,
 $V_{DS} = 25\text{V}$, $T_j = 25^\circ\text{C}$



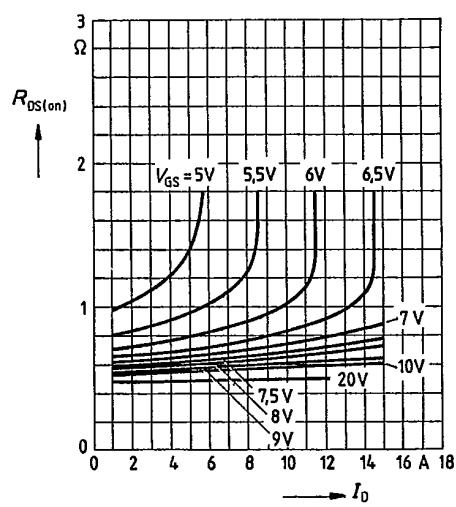
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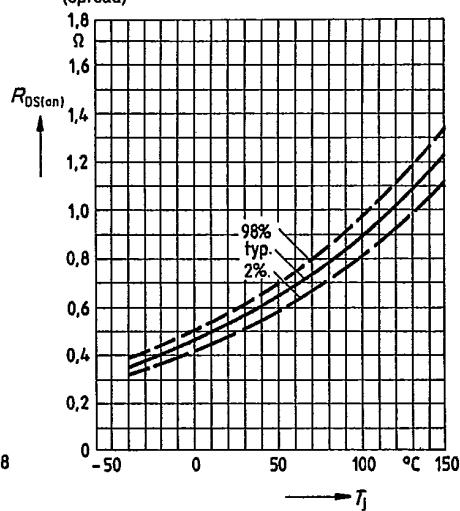
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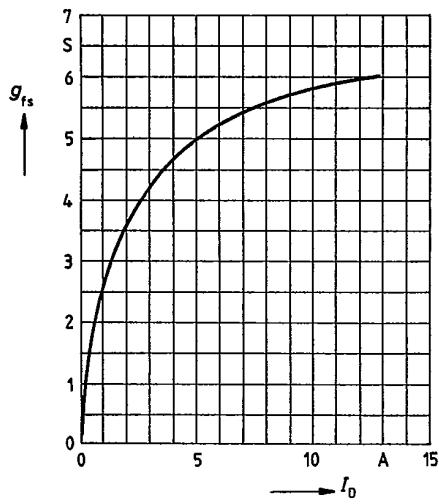
Typical drain-source on-state resistance
 $R_{DS(on)} = f(I_D)$
 parameter: $V_{GS} = 10V$, $T_J = 25^\circ C$



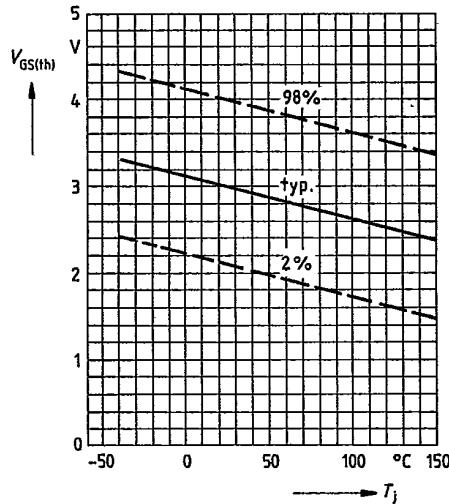
Drain-source on-state resistance
 $R_{DS(on)} = f(T_J)$
 parameter: $I_D = 5.5A$, $V_{GS} = 10V$
 (spread)



Typical transconductance $g_{fs} = f(I_D)$
 parameter: 80 μ s pulse test,
 $V_{DS} = 25V$, $T_J = 25^\circ C$



Gate threshold voltage $V_{GS(th)} = f(T_J)$
 parameter: $V_{DS} = V_{GS}$, $I_D = 1mA$
 (spread)



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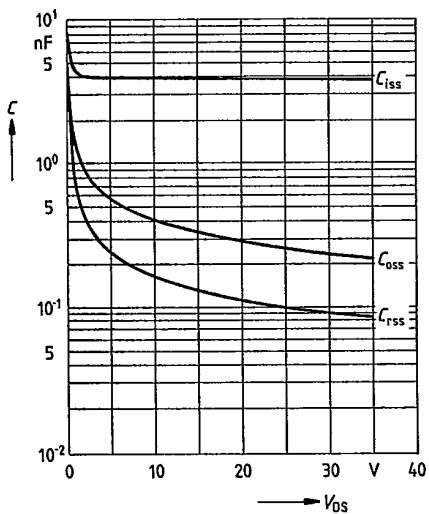
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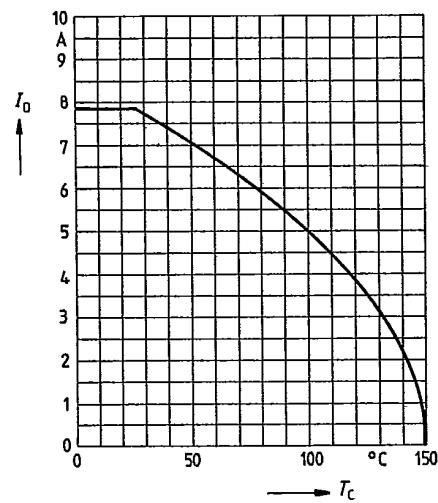
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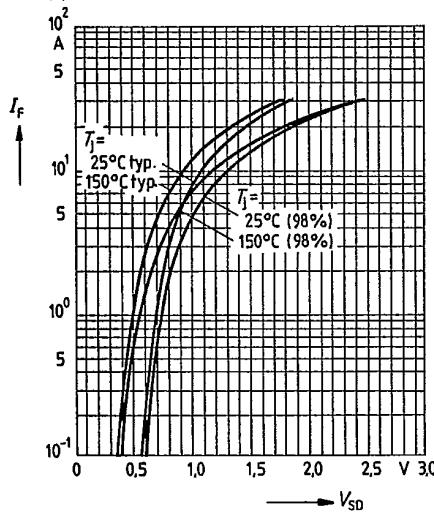
Typical capacitances $C = f(V_{DS})$
parameter: $V_{GS} = 0$, $f = 1\text{MHz}$



Continuous drain current $I_D = f(T_C)$
parameter: $V_{GS} \geq 10\text{V}$

**Forward characteristic of reverse diode**

$I_F = f(V_{SD})$
parameter: T_J , $t_p = 80 \mu\text{s}$
(spread)



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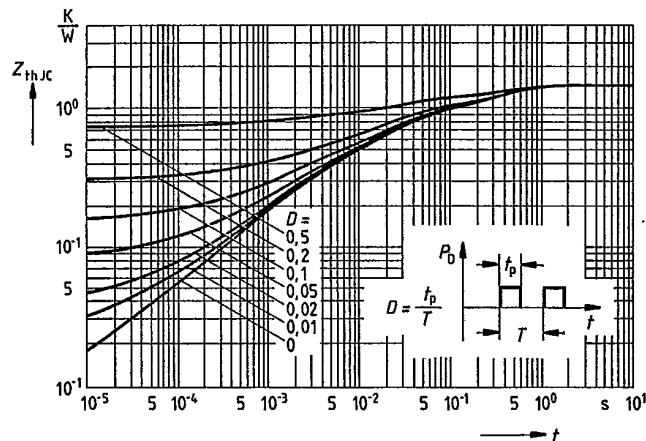
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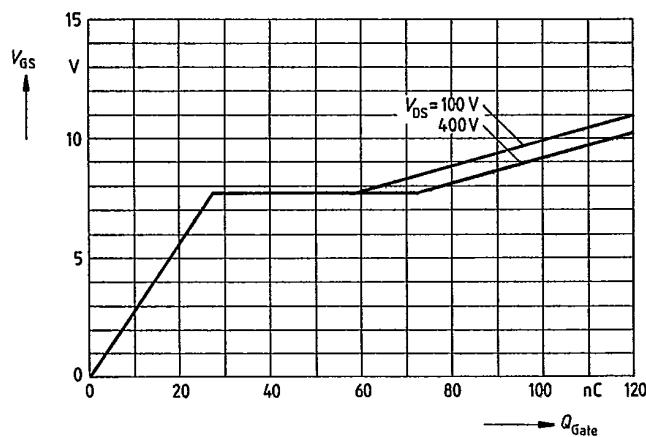
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Transient thermal impedance $Z_{thJC} = f(t)$
parameter: $D = t_p/T$



Typical gate-charge $V_{GS} = f(Q_{Gate})$
parameter: $I_D \text{ puls} = 14.4A$



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